

Search Notes**Application/Control No.**

10/053,079

Examiner

Binh Q. Nguyen

Applicant(s)/Patent under Reexamination

FLEISCHER ET AL.

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	238	10/11/2005	BQN
370	238.1	10/11/2005	BQN
370	218	10/11/2005	BQN
370	217	10/11/2005	BQN
370	225	10/11/2005	BQN
370	228	10/11/2005	BQN
370	237	10/11/2005	BQN
709	239	10/11/2005	BQN
701	202	10/11/2005	BQN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB) see more on search history.	10/11/2005	BQN
Consulted with Wellington Chin	10/11/2005	BQN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	239	10/11/2005	BQN
701	202	10/11/2005	BQN